


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,765	WU ET AL.	
	Examiner	Art Unit	
	Thien F. Tran	2811	

SEARCHED			
Class	Subclass	Date	Examiner
257	324-325	1/19/2005	TT
438	216, 261	1/19/2005	TT
438	591, 593	1/19/2005	TT
257	316-317	1/19/2005	TT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	324, 325	1/19/2005	TT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR